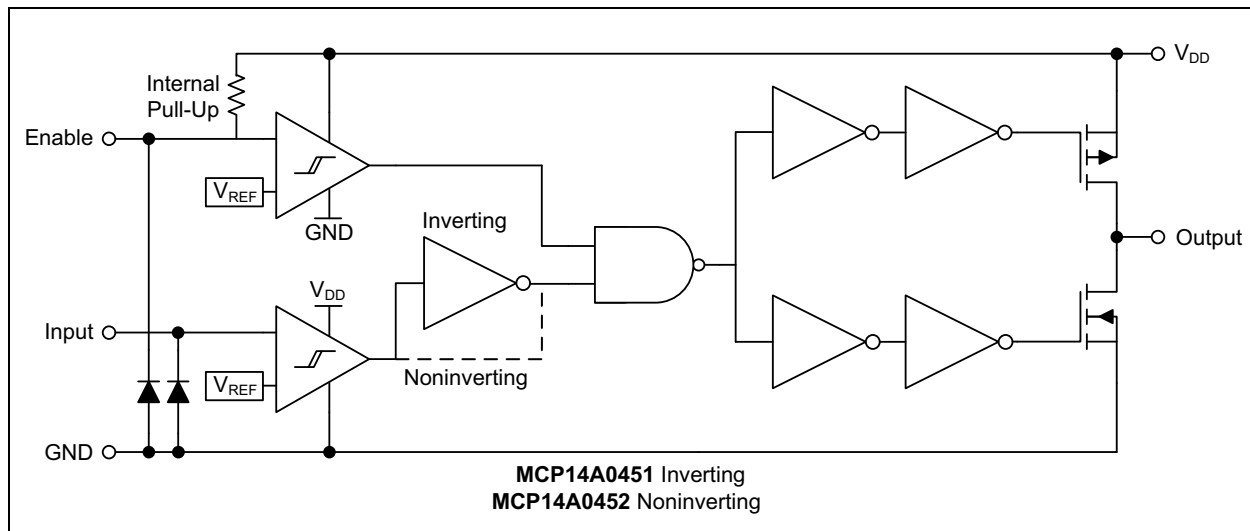




MCP14A0451/2

Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

1.1 Electrical Specifications

Absolute Maximum Ratings †

V _{DD} , Supply Voltage.....	+20V
V _{IN} , Input Voltage	(V _{DD} + 0.3V) to (GND - 0.3V)
V _{EN} , Enable Voltage.....	(V _{DD} + 0.3V) to (GND - 0.3V)
Package Power Dissipation (T _A = +50°C)	
8L MSOP	0.58W
8L SOIC	0.90W
8L 2 X 2 WDFN	1.63W
ESD protection on all pins	2 kV (HBM)
ESD protection on all pins	200V (MM)

† **Notice:** Stresses above those listed under “Maximum ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

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TABLE 1-1: DC CHARACTERISTICS

Electrical Specifications: Unless otherwise noted, $T_A = +25^{\circ}\text{C}$, with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Input						
Input Voltage Range	V_{IN}	GND - 0.3V	—	$V_{DD} + 0.3$	V	
Logic '1' High Input Voltage	V_{IH}	2.0	1.6	—	V	
Logic '0' Low Input Voltage	V_{IL}	—	1.3	0.8	V	
Input Voltage Hysteresis	$V_{HYST(IN)}$	—	0.3	—	V	
Input Current	I_{IN}	-1	—	+1	μA	$0\text{V} \leq V_{IN} \leq V_{DD}$
Enable						
Enable Voltage Range	V_{EN}	GND - 0.3V	—	$V_{DD} + 0.3$	V	
Logic '1' High Enable Voltage	V_{EH}	2.0	1.6	—	V	
Logic '0' Low Enable Voltage	V_{EL}	—	1.3	0.8	V	
Enable Voltage Hysteresis	$V_{HYST(EN)}$	—	0.3	—	V	
Enable Pin Pull-Up Resistance	R_{ENBL}	—	1.5	—	M Ω	$V_{DD} = 18\text{V}$, $ENB = A_{GND}$
Enable Input Current	I_{EN}	—	12	—	μA	$V_{DD} = 18\text{V}$, $ENB = A_{GND}$
Propagation Delay	t_{D3}	—	15	22	ns	$V_{DD} = 18\text{V}$, $V_{EN} = 5\text{V}$, see Figure 4-3 , (Note 1)
Propagation Delay	t_{D4}	—	20	27	ns	$V_{DD} = 18\text{V}$, $V_{EN} = 5\text{V}$, see Figure 4-3 , (Note 1)
Output						
High Output Voltage	V_{OH}	$V_{DD} - 0.025$	—	—	V	$I_{OUT} = 0\text{A}$
Low Output Voltage	V_{OL}	—	—	0.025	V	$I_{OUT} = 0\text{A}$
Output Resistance, High	R_{OH}	—	1.6	2.6	Ω	$I_{OUT} = 10\text{ mA}$, $V_{DD} = 18\text{V}$
Output Resistance, Low	R_{OL}	—	1.2	2.2	Ω	$I_{OUT} = 10\text{ mA}$, $V_{DD} = 18\text{V}$
Peak Output Current	I_{PK}	—	4.5	—	A	$V_{DD} = 18\text{V}$ (Note 1)
Latch-Up Protection Withstand Reverse Current	I_{REV}	0.5	—	—	A	Duty cycle $\leq 2\%$, $t \leq 300\text{ }\mu\text{s}$ (Note 1)
Switching Time (Note 1)						
Rise Time	t_R	—	9.5	14	ns	$V_{DD} = 18\text{V}$, $C_L = 2200\text{ pF}$, see Figure 4-1 , Figure 4-2
Fall Time	t_F	—	9	14	ns	$V_{DD} = 18\text{V}$, $C_L = 2200\text{ pF}$, see Figure 4-1 , Figure 4-2
Delay Time	t_{D1}	—	16	23	ns	$V_{DD} = 18\text{V}$, $V_{IN} = 5\text{V}$, see Figure 4-1 , Figure 4-2
	t_{D2}	—	19.5	26.5	ns	$V_{DD} = 18\text{V}$, $V_{IN} = 5\text{V}$, see Figure 4-1 , Figure 4-2
Power Supply						
Supply Voltage	V_{DD}	4.5	—	18	V	
Power Supply Current	I_{DD}	—	355	580	μA	$V_{IN} = 3\text{V}$, $V_{EN} = 3\text{V}$
	I_{DD}	—	355	580	μA	$V_{IN} = 0\text{V}$, $V_{EN} = 3\text{V}$
	I_{DD}	—	355	580	μA	$V_{IN} = 3\text{V}$, $V_{EN} = 0\text{V}$
	I_{DD}	—	355	580	μA	$V_{IN} = 0\text{V}$, $V_{EN} = 0\text{V}$

Note 1: Tested during characterization, not production tested.

TABLE 1-2: DC CHARACTERISTICS (OVER OPERATING TEMP. RANGE)

Electrical Specifications: Unless otherwise indicated, over the operating range with $4.5V \leq V_{DD} \leq 18V$.						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Input						
Input Voltage Range	V_{IN}	GND - 0.3V	—	$V_{DD} + 0.3$	V	
Logic '1' High Input Voltage	V_{IH}	2.0	1.6	—	V	
Logic '0' Low Input Voltage	V_{IL}	—	1.3	0.8	V	
Input Voltage Hysteresis	$V_{HYST(IN)}$	—	0.3	—	V	
Input Current	I_{IN}	-10	—	+10	μA	$0V \leq V_{IN} \leq V_{DD}$
Enable						
Enable Voltage Range	V_{EN}	GND - 0.3V	—	$V_{DD} + 0.3$	V	
Logic '1' High Enable Voltage	V_{EH}	2.0	1.6	—	V	
Logic '0' Low Enable Voltage	V_{EL}	—	1.3	0.8	V	
Enable Voltage Hysteresis	$V_{HYST(EN)}$	—	0.3	—	V	
Enable Input Current	I_{EN}	—	12	—	μA	$V_{DD} = 18V, ENB = A_{GND}$
Propagation Delay	t_{D3}	—	19	26	ns	$V_{DD} = 18V, V_{EN} = 5V, T_A = +125^\circ C$, see Figure 4-3
Propagation Delay	t_{D4}	—	24	31	ns	$V_{DD} = 18V, V_{EN} = 5V, T_A = +125^\circ C$, see Figure 4-3
Output						
High Output Voltage	V_{OH}	$V_{DD} - 0.025$	—	—	V	DC Test
Low Output Voltage	V_{OL}	—	—	0.025	V	DC Test
Output Resistance, High	R_{OH}	—	—	3.5	Ω	$I_{OUT} = 10\text{ mA}, V_{DD} = 18V$
Output Resistance, Low	R_{OL}	—	—	3	Ω	$I_{OUT} = 10\text{ mA}, V_{DD} = 18V$

Note 1: Tested during characterization, not production tested.

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TABLE 1-2: DC CHARACTERISTICS (OVER OPERATING TEMP. RANGE) (CONTINUED)

Electrical Specifications: Unless otherwise indicated, over the operating range with $4.5V \leq V_{DD} \leq 18V$.						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Switching Time (Note 1)						
Rise Time	t_R	—	11.5	16.5	ns	$V_{DD} = 18V$, $C_L = 2200$ pF, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2
Fall Time	t_F	—	11.5	16.5	ns	$V_{DD} = 18V$, $C_L = 2200$ pF, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2
Delay Time	t_{D1}	—	20	27	ns	$V_{DD} = 18V$, $V_{IN} = 5V$, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2
	t_{D2}	—	24.5	31.5		$V_{DD} = 18V$, $V_{IN} = 5V$, $T_A = +125^\circ C$, see Figure 4-1, Figure 4-2
Power Supply						
Supply Voltage	V_{DD}	4.5	—	18	V	
Power Supply Current	I_{DD}	—	—	700	uA	$V_{IN} = 3V$, $V_{EN} = 3V$
	I_{DD}	—	—	700	uA	$V_{IN} = 0V$, $V_{EN} = 3V$
	I_{DD}	—	—	700	uA	$V_{IN} = 3V$, $V_{EN} = 0V$
	I_{DD}	—	—	700	uA	$V_{IN} = 0V$, $V_{EN} = 0V$

Note 1: Tested during characterization, not production tested.

1.2 Temperature Characteristics

Electrical Specifications: Unless otherwise noted, all parameters apply with $4.5V \leq V_{DD} \leq 18V$						
Parameter	Sym.	Min.	Typ.	Max.	Units	Comments
Temperature Ranges						
Specified Temperature Range	T _A	-40	—	+125	°C	
Maximum Junction Temperature	T _J	—	—	+150	°C	
Storage Temperature Range	T _A	-65	—	+150	°C	
Package Thermal Resistances						
Junction-to-Ambient Thermal Resistance, 8LD MSOP	θ _{JA}	—	172	—	°C/W	Note 1
Junction-to-Ambient Thermal Resistance, 8LD SOIC	θ _{JA}	—	111	—	°C/W	Note 1
Junction-to-Ambient Thermal Resistance, 8LD WDFN	θ _{JA}	—	61	—	°C/W	Note 1
Junction-to-Top Characterization Parameter, 8LD MSOP	Ψ _{JT}	—	7	—	°C/W	Note 1
Junction-to-Top Characterization Parameter, 8LD SOIC	Ψ _{JT}	—	12	—	°C/W	Note 1
Junction-to-Top Characterization Parameter, 8LD WDFN	Ψ _{JT}	—	1.6	—	°C/W	Note 1
Junction-to-Board Characterization Parameter, 8LD MSOP	Ψ _{JB}	—	130	—	°C/W	Note 1
Junction-to-Board Characterization Parameter, 8LD SOIC	Ψ _{JB}	—	76	—	°C/W	Note 1
Junction-to-Board Characterization Parameter, 8LD WDFN	Ψ _{JB}	—	29	—	°C/W	Note 1

Note 1: Parameter is determined using High K 2S2P 4-Layer board as described in JESD 51-7, as well as JESD 51-5 for packages with exposed pads

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.

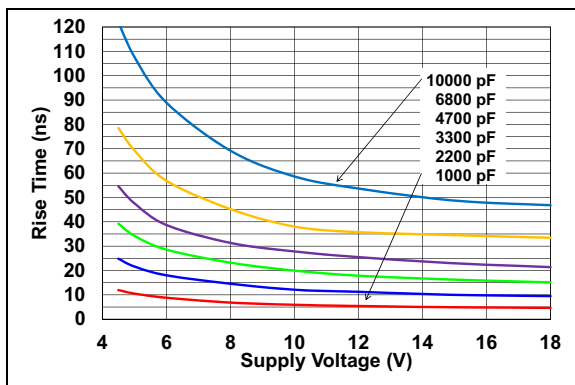


FIGURE 2-1: Rise Time vs. Supply Voltage.

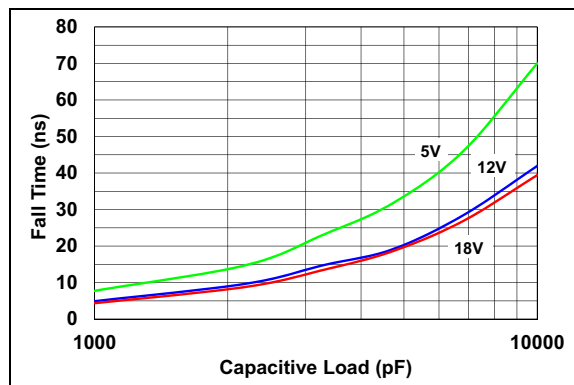


FIGURE 2-4: Fall Time vs. Capacitive Load.

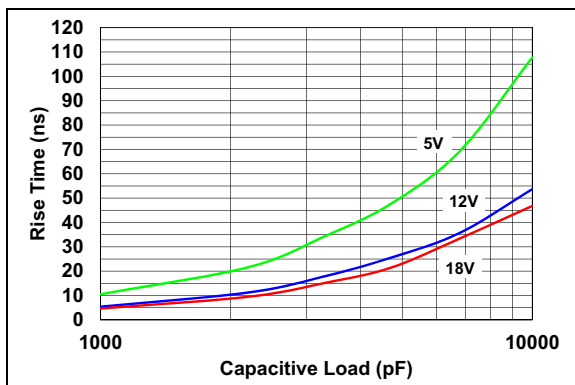


FIGURE 2-2: Rise Time vs. Capacitive Load.

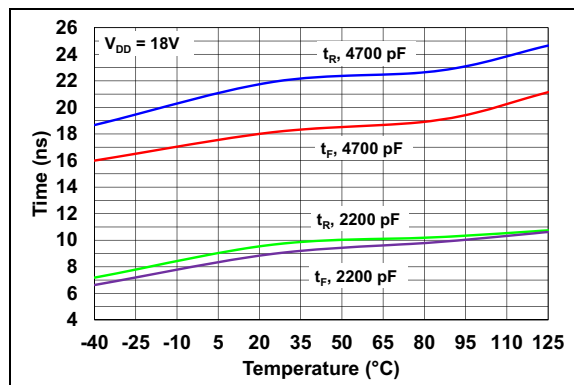


FIGURE 2-5: Rise and Fall Time vs. Temperature.

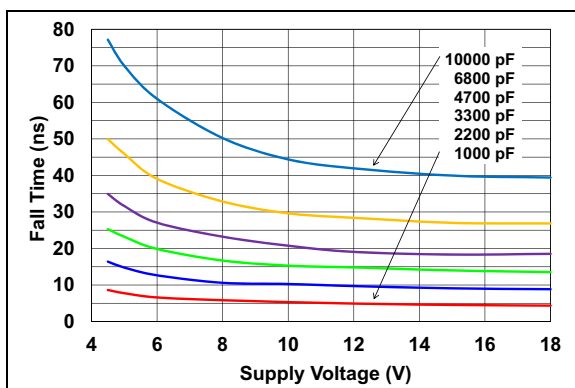


FIGURE 2-3: Fall Time vs. Supply Voltage.

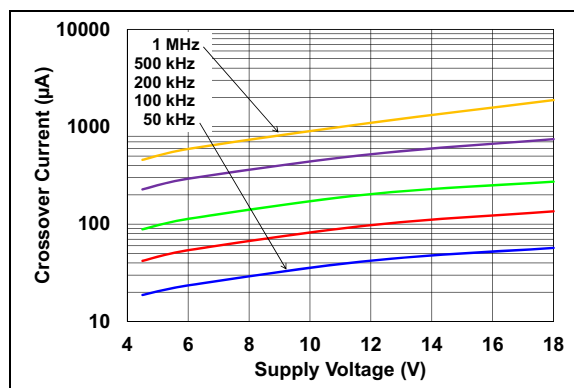


FIGURE 2-6: Crossover Current vs. Supply Voltage.

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Note: Unless otherwise indicated, $T_A = +25^{\circ}\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.

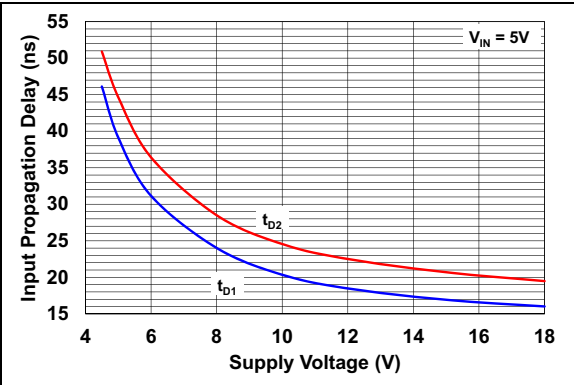


FIGURE 2-7: Input Propagation Delay vs. Supply Voltage.

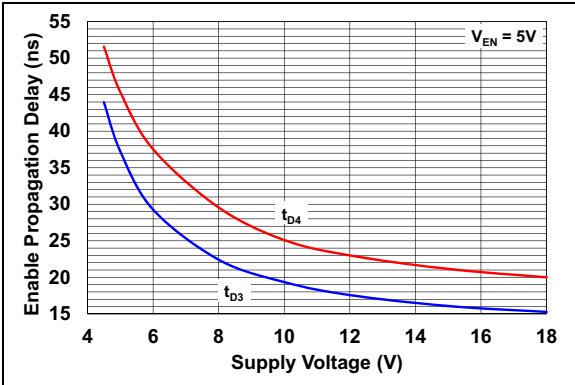


FIGURE 2-10: Enable Propagation Delay vs. Supply Voltage.

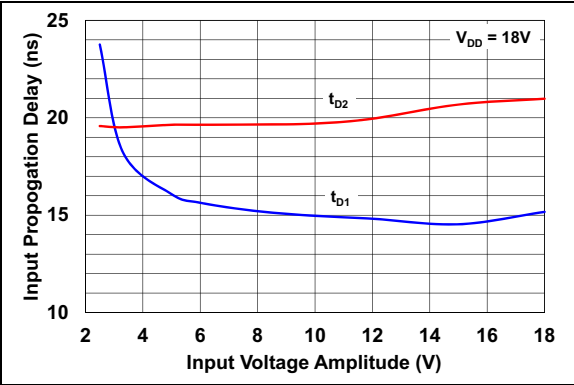


FIGURE 2-8: Input Propagation Delay Time vs. Input Amplitude.

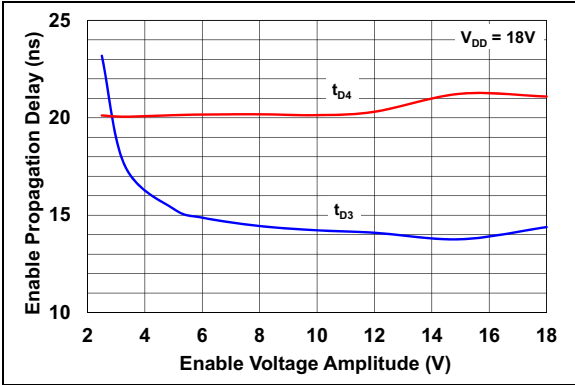


FIGURE 2-11: Enable Propagation Delay Time vs. Enable Voltage Amplitude.

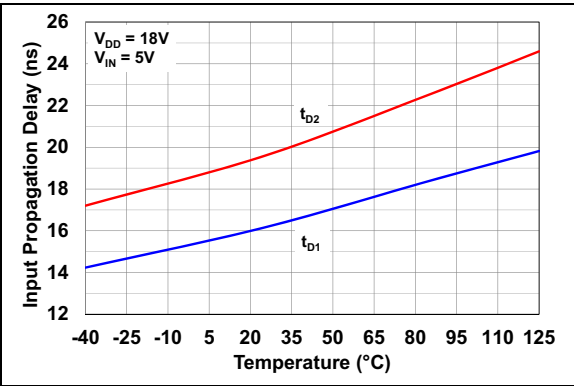


FIGURE 2-9: Input Propagation Delay vs. Temperature.

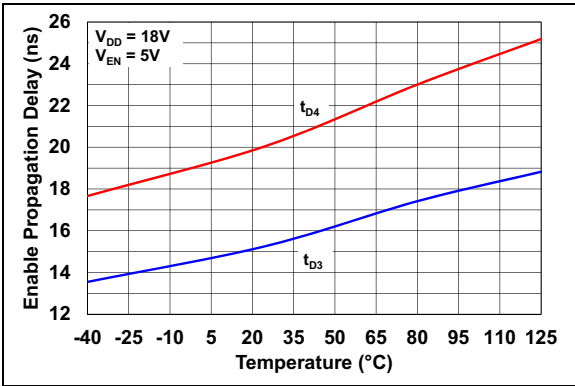


FIGURE 2-12: Enable Propagation Delay vs. Temperature.

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.

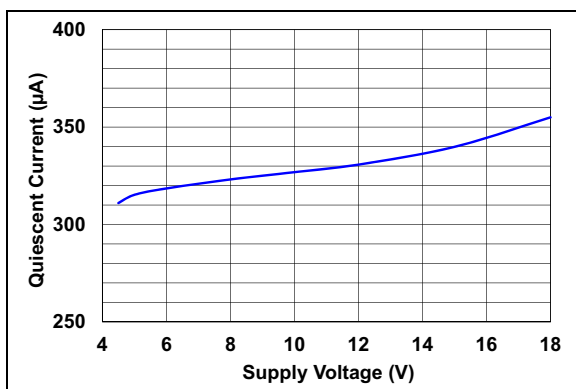


FIGURE 2-13: Quiescent Supply Current vs. Supply Voltage.

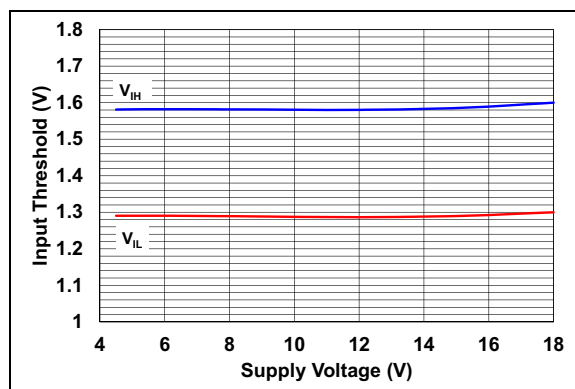


FIGURE 2-16: Input Threshold vs Supply Voltage.

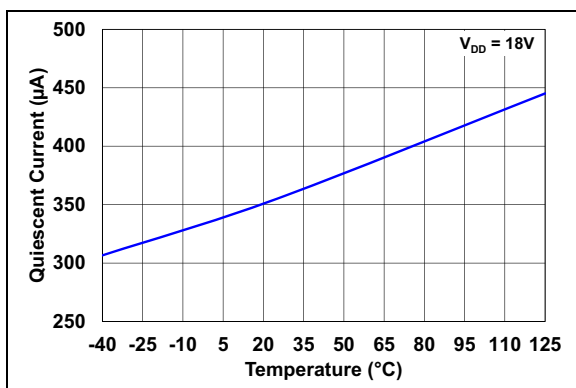


FIGURE 2-14: Quiescent Supply Current vs. Temperature.

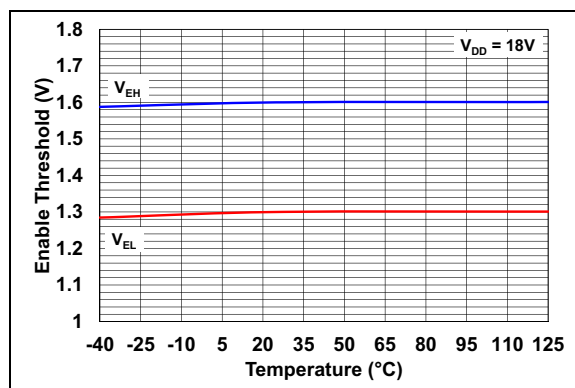


FIGURE 2-17: Enable Threshold vs. Temperature.

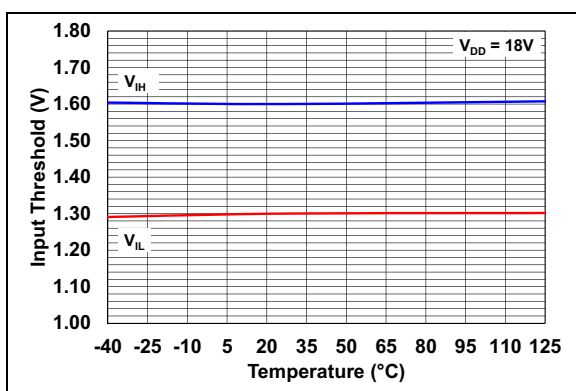


FIGURE 2-15: Input Threshold vs. Temperature.

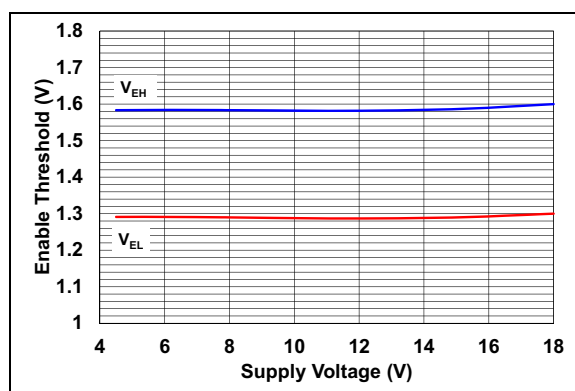


FIGURE 2-18: Enable Threshold vs Supply Voltage.

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Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.

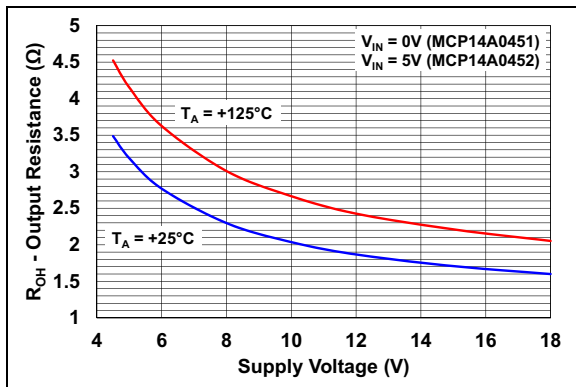


FIGURE 2-19: Output Resistance (Output High) vs. Supply Voltage.

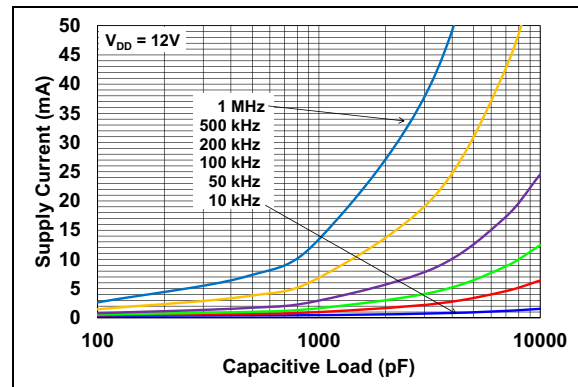


FIGURE 2-22: Supply Current vs. Capacitive Load ($V_{DD} = 12\text{V}$).

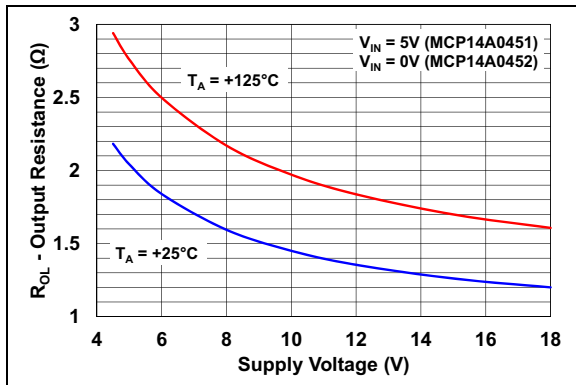


FIGURE 2-20: Output Resistance (Output Low) vs. Supply Voltage.

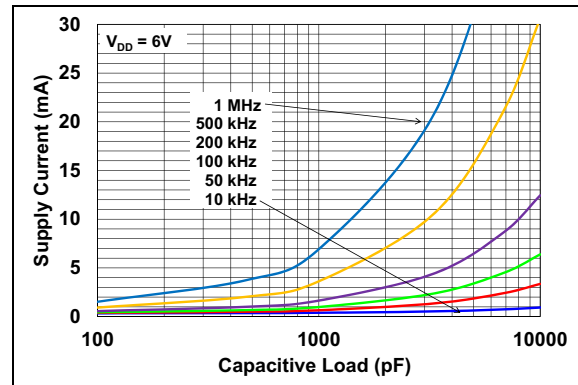


FIGURE 2-23: Supply Current vs. Capacitive Load ($V_{DD} = 6\text{V}$).

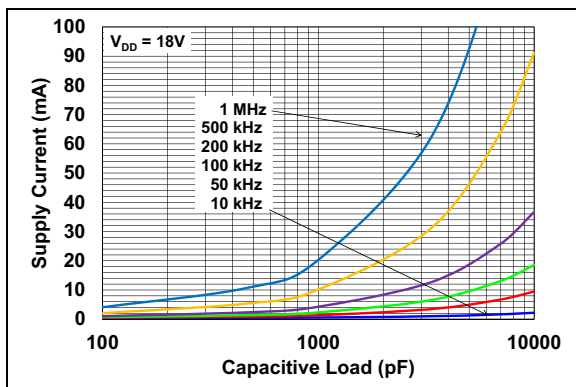


FIGURE 2-21: Supply Current vs. Capacitive Load ($V_{DD} = 18\text{V}$).

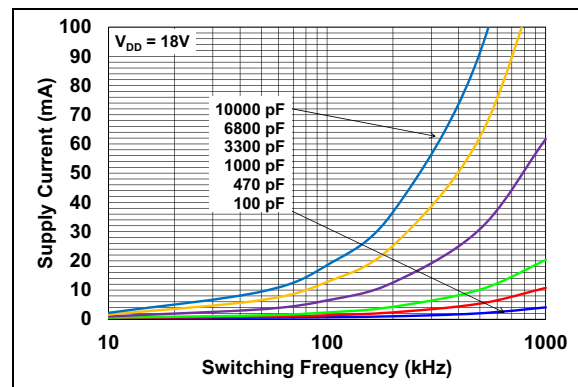


FIGURE 2-24: Supply Current vs. Frequency ($V_{DD} = 18\text{V}$).

Note: Unless otherwise indicated, $T_A = +25^\circ\text{C}$ with $4.5\text{V} \leq V_{DD} \leq 18\text{V}$.

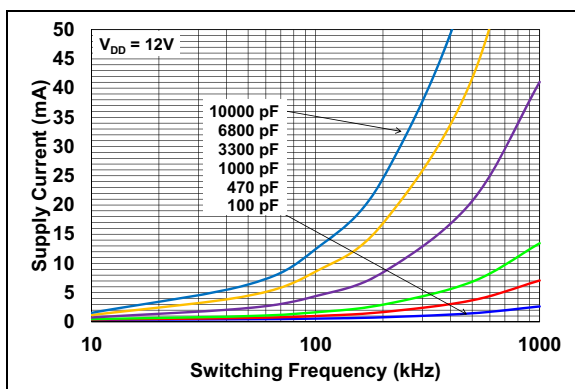


FIGURE 2-25: Supply Current vs. Frequency ($V_{DD} = 12\text{V}$).

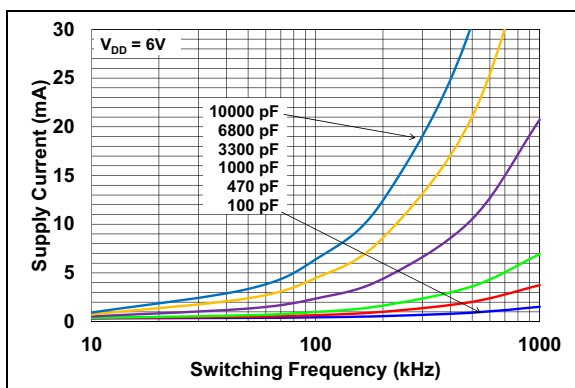


FIGURE 2-26: Supply Current vs. Frequency ($V_{DD} = 6\text{V}$).

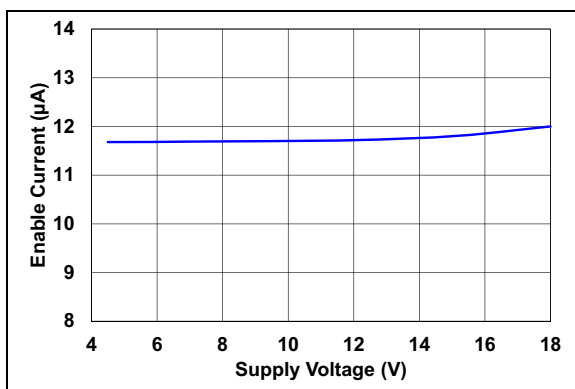


FIGURE 2-27: Enable Current vs. Supply Voltage.

NOTES:

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in [Table 3-1](#).

TABLE 3-1: PIN FUNCTION TABLE

MCP14A0451/2		Symbol	Description
8L 2 x 2 WDFN	8L MSOP/SOIC		
1	1	V_{DD}	Supply Input
2	2	IN	Control Input
3	3	EN	Device Enable
4	4	GND	Power Ground
5	5	GND	Power Ground
6	6	$\overline{\text{OUT}}/\text{OUT}$	Push-Pull Output
7	7	$\overline{\text{OUT}}/\text{OUT}$	Push-Pull Output
8	8	V_{DD}	Supply Input
EP	—	EP	Exposed Thermal Pad (GND)

3.1 Output Pin ($\overline{\text{OUT}}$, OUT)

The Output is a CMOS push-pull output that is capable of sourcing and sinking 4.5A of peak current ($V_{DD} = 18V$). The low output impedance ensures the gate of the external MOSFET stays in the intended state even during large transients. This output also has a reverse current latch-up rating of 500 mA.

3.2 Power Ground Pin (GND)

GND is the device return pin for the input and output stages. The GND pin should have a low-impedance connection to the bias supply source return. When the capacitive load is being discharged, high peak currents will flow out of the ground pin.

3.3 Device Enable Pin (EN)

The MOSFET driver Device Enable is a high-impedance input featuring low threshold levels. The Enable input also has hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals and to provide noise immunity. Driving the Enable pin below the threshold will disable the output of the device, pulling $\overline{\text{OUT}}/\text{OUT}$ low, regardless of the status of the Input pin. Driving the Enable pin above the threshold allows normal operation of the $\overline{\text{OUT}}/\text{OUT}$ pin based on the status of the Input pin. The Enable pin utilizes an internal pull up resistor, allowing the pin to be left floating for standard driver operation.

3.4 Control Input Pin (IN)

The MOSFET driver Control Input is a high-impedance input featuring low threshold levels. The Input also has hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals and to provide noise immunity.

3.5 Supply Input Pin (V_{DD})

V_{DD} is the bias supply input for the MOSFET driver and has a voltage range of 4.5V to 18V. This input must be decoupled to ground with a local capacitor. This bypass capacitor provides a localized low-impedance path for the peak currents that are provided to the load.

3.6 Exposed Metal Pad Pin (EP)

The exposed metal pad of the WDFN package is internally connected to GND. Therefore, this pad should be connected to a Ground plane to aid in heat removal from the package.

NOTES:

4.0 APPLICATION INFORMATION

4.1 General Information

MOSFET drivers are high-speed, high-current devices which are intended to source/sink high-peak currents to charge/discharge the gate capacitance of external MOSFETs or Insulated-Gate Bipolar Transistors (IGBTs). In high frequency switching power supplies, the Pulse-Width Modulation (PWM) controller may not have the drive capability to directly drive the power MOSFET. A MOSFET driver such as the MCP14A0451/2 family can be used to provide additional source/sink current capability.

4.2 MOSFET Driver Timing

The ability of a MOSFET driver to transition from a fully-off state to a fully-on state is characterized by the driver's rise time (t_R), fall time (t_F) and propagation delays (t_{D1} and t_{D2}). Figure 4-1 and Figure 4-2 show the test circuit and timing waveform used to verify the MCP14A0451/2 timing.

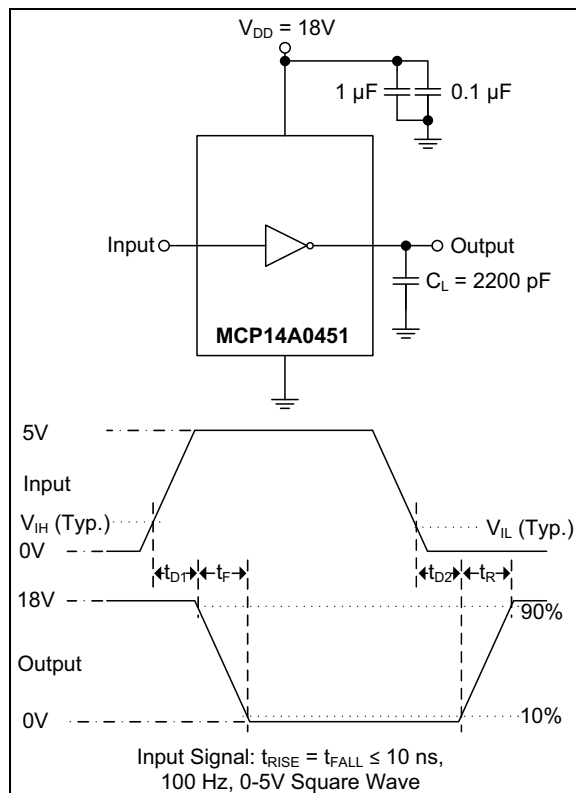


FIGURE 4-1: Inverting Driver Timing Waveform.

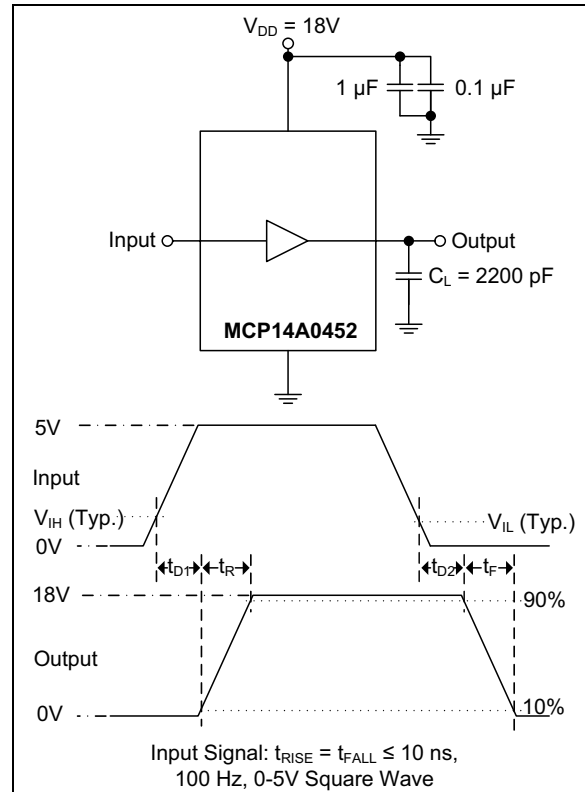


FIGURE 4-2: Noninverting Driver Timing Waveform.

4.3 Enable Function

The enable pin (EN) provides additional control of the output pin (OUT). This pin is active high and is internally pulled up to V_{DD} so that the pin can be left floating to provide standard MOSFET driver operation.

When the enable pin's input voltage is above the enable pin high voltage threshold, (V_{EN_H}), the output is enabled and allowed to react to the status of the Input pin. However, when the voltage applied to the Enable pin falls below the low threshold voltage (V_{EN_L}), the driver's output is disabled and doesn't respond to changes in the status of the Input pin. When the driver is disabled, the output is pulled down to a low state. Refer to Table 4-1 for enable pin logic. The threshold voltage levels for the Enable pin are similar to the threshold voltage levels of the Input pin. Hysteresis is provided to help increase the noise immunity of the enable function, avoiding false triggers of the enable signal during driver switching.

There are propagation delays associated with the driver receiving an enable signal and the output reacting. These propagation delays, t_{D3} and t_{D4} , are graphically represented in Figure 4-3.

MCP14A0451/2

TABLE 4-1: ENABLE PIN LOGIC

ENB	IN	MCP14A0151 OUT	MCP14A0152 OUT
H	H	L	H
H	L	H	L
L	X	L	L

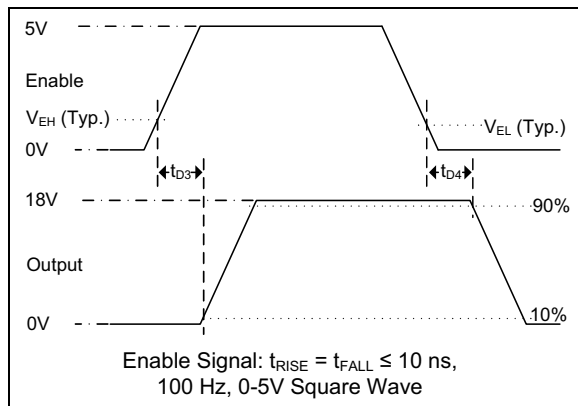


FIGURE 4-3: Enable Timing Waveform.

4.4 Decoupling Capacitors

Careful PCB layout and decoupling capacitors are required when using power MOSFET drivers. Large current is required to charge and discharge capacitive loads quickly. For example, approximately 720 mA are needed to charge a 1000 pF load with 18V in 25 ns.

To operate the MOSFET driver over a wide frequency range with low supply impedance, it is recommended to place 1.0 μF and 0.1 μF low ESR ceramic capacitors in parallel between the driver V_{DD} and GND. These capacitors should be placed close to the driver to minimize circuit board parasitics and provide a local source for the required current.

4.5 PCB Layout Considerations

Proper Printed Circuit Board (PCB) layout is important in high-current, fast switching circuits to provide proper device operation and robustness of design. Improper component placement may cause errant switching, excessive voltage ringing or circuit latch-up. The PCB trace loop length and inductance should be minimized by the use of ground planes or traces under the MOSFET gate drive signal. Separate analog and power grounds and local driver decoupling should also be used.

Placing a ground plane beneath the MCP14A0451/2 devices will help as a radiated noise shield, as well as providing some heat sinking for power dissipated within the device.

4.6 Power Dissipation

The total internal power dissipation in a MOSFET driver is the summation of three separate power dissipation elements, as shown in Equation 4-1.

EQUATION 4-1:

$$P_T = P_L + P_Q + P_{CC}$$

Where:

- P_T = Total power dissipation
- P_L = Load power dissipation
- P_Q = Quiescent power dissipation
- P_{CC} = Operating power dissipation

4.6.1 CAPACITIVE LOAD DISSIPATION

The power dissipation caused by a capacitive load is a direct function of the frequency, total capacitive load and supply voltage. The power lost in the MOSFET driver for a complete charging and discharging cycle of a MOSFET is shown in Equation 4-2.

EQUATION 4-2:

$$P_L = f \times C_T \times V_{DD}^2$$

Where:

- f = Switching frequency
- C_T = Total load capacitance
- V_{DD} = MOSFET driver supply voltage

4.6.2 QUIESCENT POWER DISSIPATION

The power dissipation associated with the quiescent current draw depends on the state of the Input and Enable pins. See Section 1.0 “Electrical Characteristics” for typical quiescent current draw values in different operating states. The quiescent power dissipation is shown in Equation 4-3.

EQUATION 4-3:

$$P_Q = (I_{QH} \times D + I_{QL} \times (1 - D)) \times V_{DD}$$

Where:

- I_{QH} = Quiescent current in the High state
- D = Duty cycle
- I_{QL} = Quiescent current in the Low state
- V_{DD} = MOSFET driver supply voltage

4.6.3 OPERATING POWER DISSIPATION

The operating power dissipation occurs each time the MOSFET driver output transitions because, for a very short period of time, both MOSFETs in the output stage are on simultaneously. This cross-conduction current leads to a power dissipation described in [Equation 4-4](#).

EQUATION 4-4:

$$P_{CC} = V_{DD} \times I_{CO}$$

Where:

I_{CO} = Crossover Current

V_{DD} = MOSFET driver supply voltage

NOTES:

5.0 PACKAGING INFORMATION

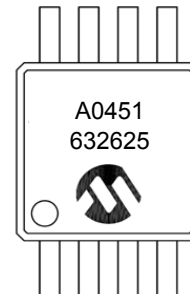
5.1 Package Marking Information

8-Lead MSOP

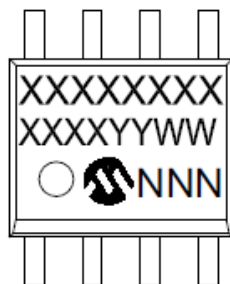


Part Number	Code
MCP14A0451-E/MS	A0451
MCP14A0451T-E/MS	A0451
MCP14A0452-E/MS	A0452
MCP14A0452T-E/MS	A0452

Example:

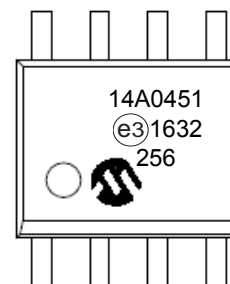


8-Lead SOIC

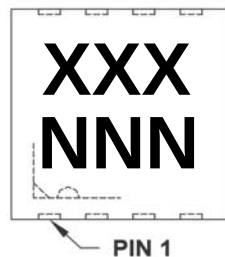


Part Number	Code
MCP14A0451-E/SN	14A0451
MCP14A0451T-E/SN	14A0451
MCP14A0452-E/SN	14A0452
MCP14A0452T-E/SN	14A0452

Example:

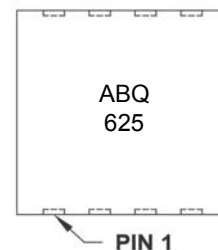


8-Lead WDFN



Part Number	Code
MCP14A0451T-E/RW	ABQ
MCP14A0452T-E/RW	ABR

Example:



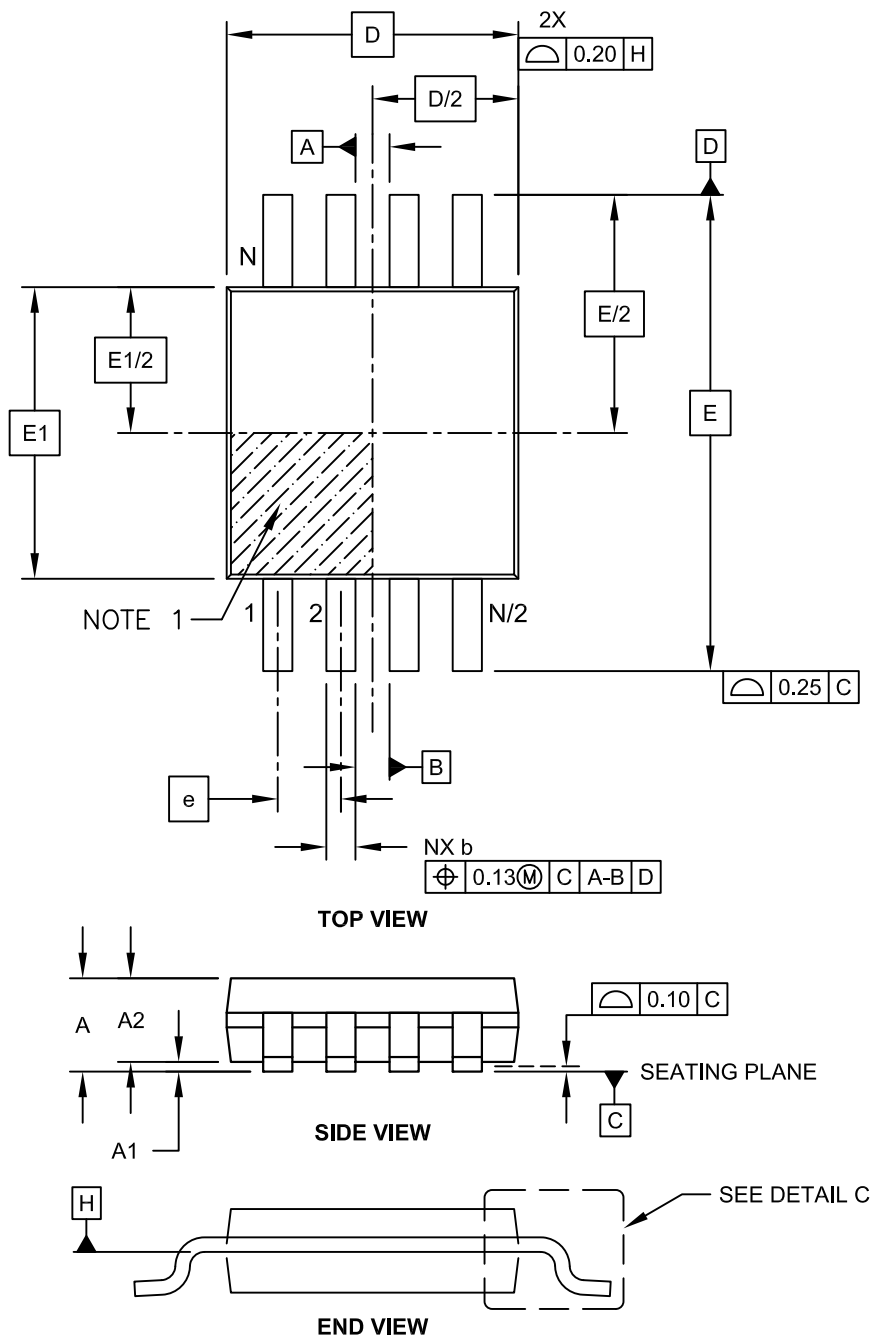
Legend: XX...X Customer-specific information
Y Year code (last digit of calendar year)
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')
NNN Alphanumeric traceability code
(e3) Pb-free JEDEC® designator for Matte Tin (Sn)
* This package is Pb-free. The Pb-free JEDEC designator (e3) can be found on the outer packaging for this package.

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

MCP14A0451/2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

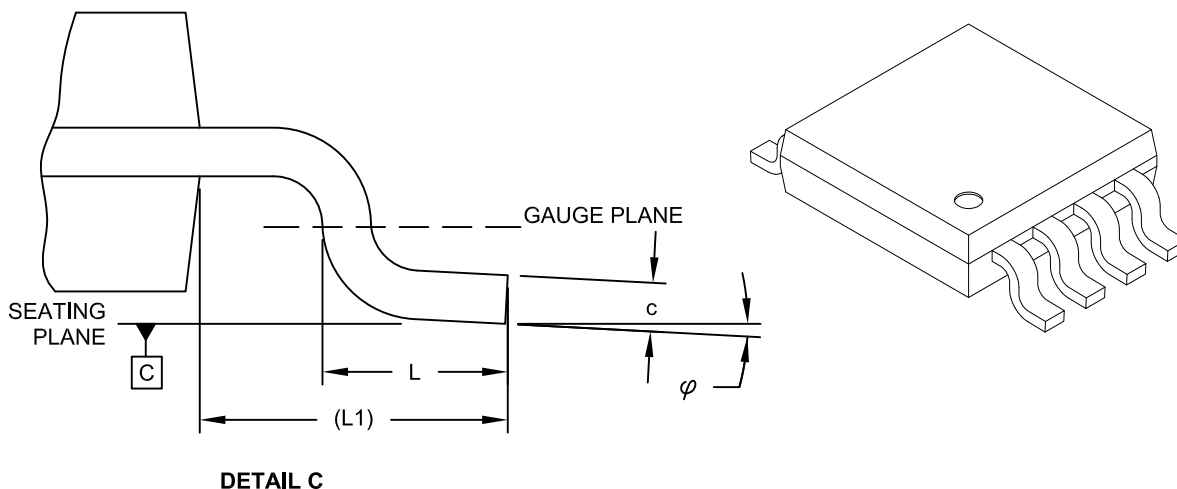
Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing C04-111C Sheet 1 of 2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Dimension Limits	Units	MILLIMETERS		
		MIN	NOM	MAX
Number of Pins	N		8	
Pitch	e	0.65 BSC		
Overall Height	A	-	-	1.10
Molded Package Thickness	A2	0.75	0.85	0.95
Standoff	A1	0.00	-	0.15
Overall Width	E	4.90 BSC		
Molded Package Width	E1	3.00 BSC		
Overall Length	D	3.00 BSC		
Foot Length	L	0.40	0.60	0.80
Footprint	L1	0.95 REF		
Foot Angle	φ	0°	-	8°
Lead Thickness	c	0.08	-	0.23
Lead Width	b	0.22	-	0.40

Notes:

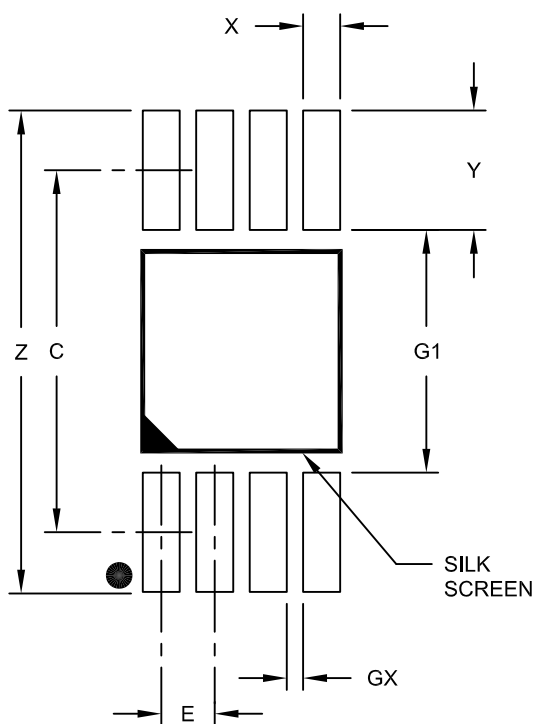
- Pin 1 visual index feature may vary, but must be located within the hatched area.
- Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- Dimensioning and tolerancing per ASME Y14.5M.
BSC: Basic Dimension. Theoretically exact value shown without tolerances.
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111C Sheet 2 of 2

MCP14A0451/2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	0.65 BSC		
Contact Pad Spacing	C		4.40	
Overall Width	Z			5.85
Contact Pad Width (X8)	X1			0.45
Contact Pad Length (X8)	Y1			1.45
Distance Between Pads	G1	2.95		
Distance Between Pads	GX	0.20		

Notes:

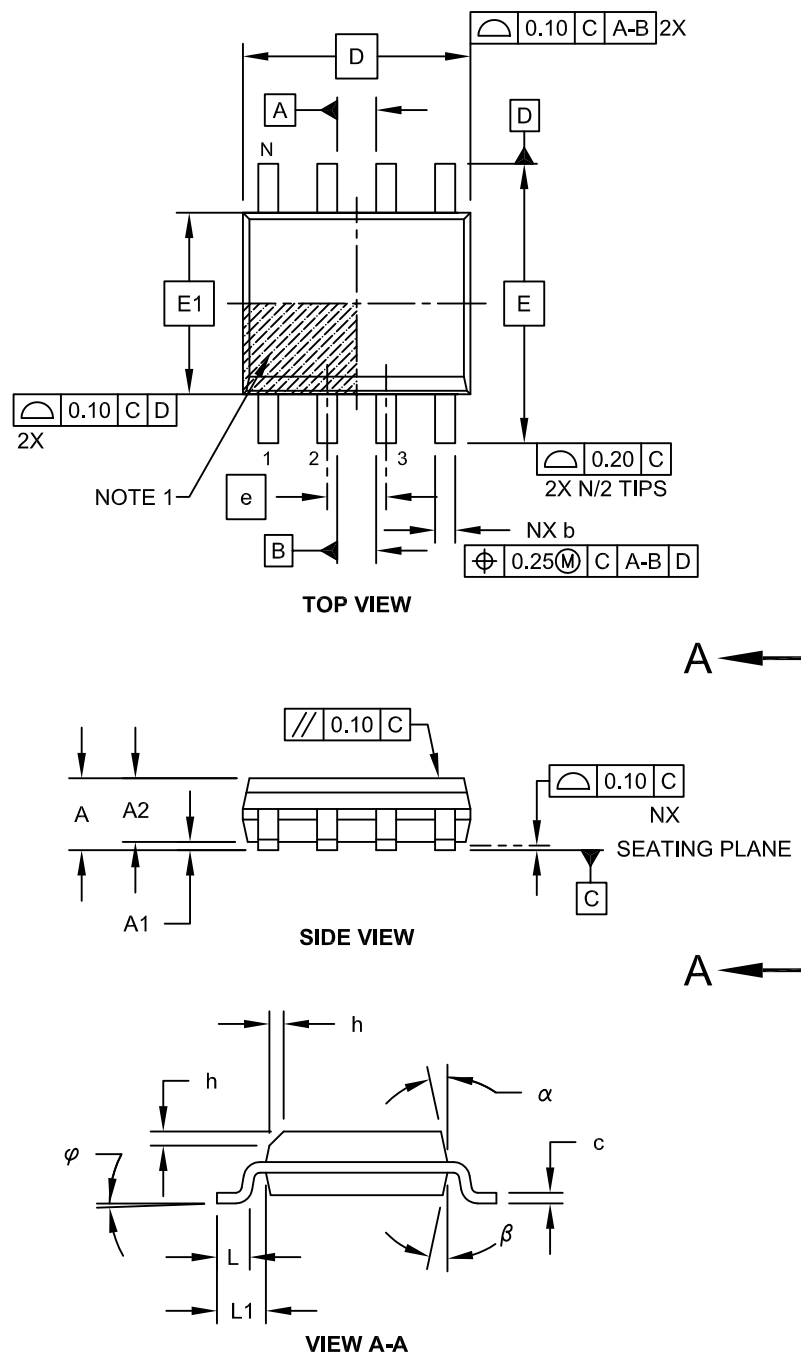
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2111A

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

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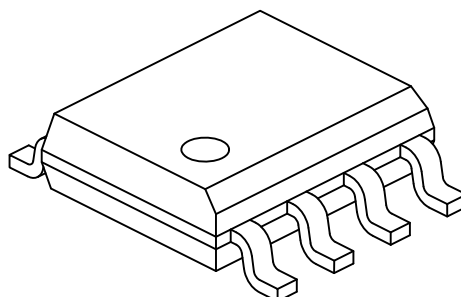


Microchip Technology Drawing No. C04-057C Sheet 1 of 2

MCP14A0451/2

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



		Units	MILLIMETERS		
Dimension Limits			MIN	NOM	MAX
Number of Pins	N		8		
Pitch	e		1.27 BSC		
Overall Height	A		-	-	1.75
Molded Package Thickness	A2		1.25	-	-
Standoff §	A1		0.10	-	0.25
Overall Width	E		6.00 BSC		
Molded Package Width	E1		3.90 BSC		
Overall Length	D		4.90 BSC		
Chamfer (Optional)	h		0.25	-	0.50
Foot Length	L		0.40	-	1.27
Footprint	L1		1.04 REF		
Foot Angle	φ		0°	-	8°
Lead Thickness	c		0.17	-	0.25
Lead Width	b		0.31	-	0.51
Mold Draft Angle Top	α		5°	-	15°
Mold Draft Angle Bottom	β		5°	-	15°

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.
2. § Significant Characteristic
3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
4. Dimensioning and tolerancing per ASME Y14.5M

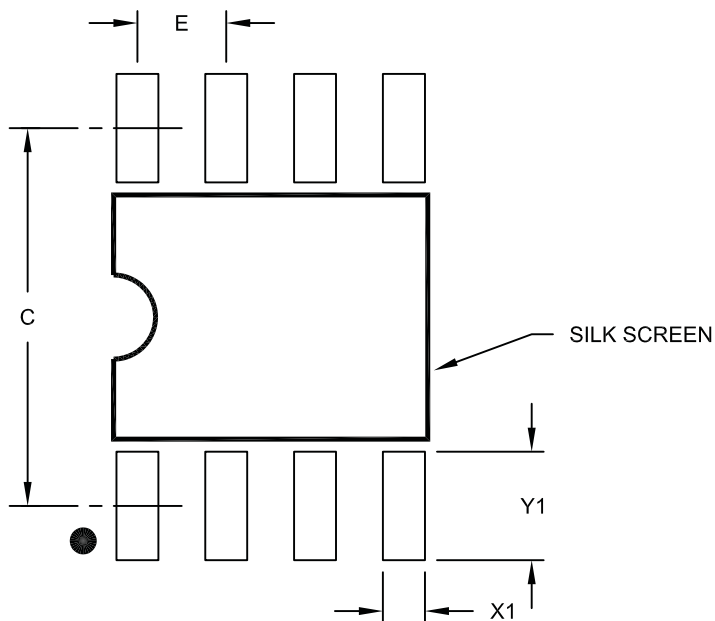
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-057C Sheet 2 of 2

8-Lead Plastic Small Outline (SN) – Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	1.27 BSC		
Contact Pad Spacing	C		5.40	
Contact Pad Width (X8)	X1			0.60
Contact Pad Length (X8)	Y1			1.55

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

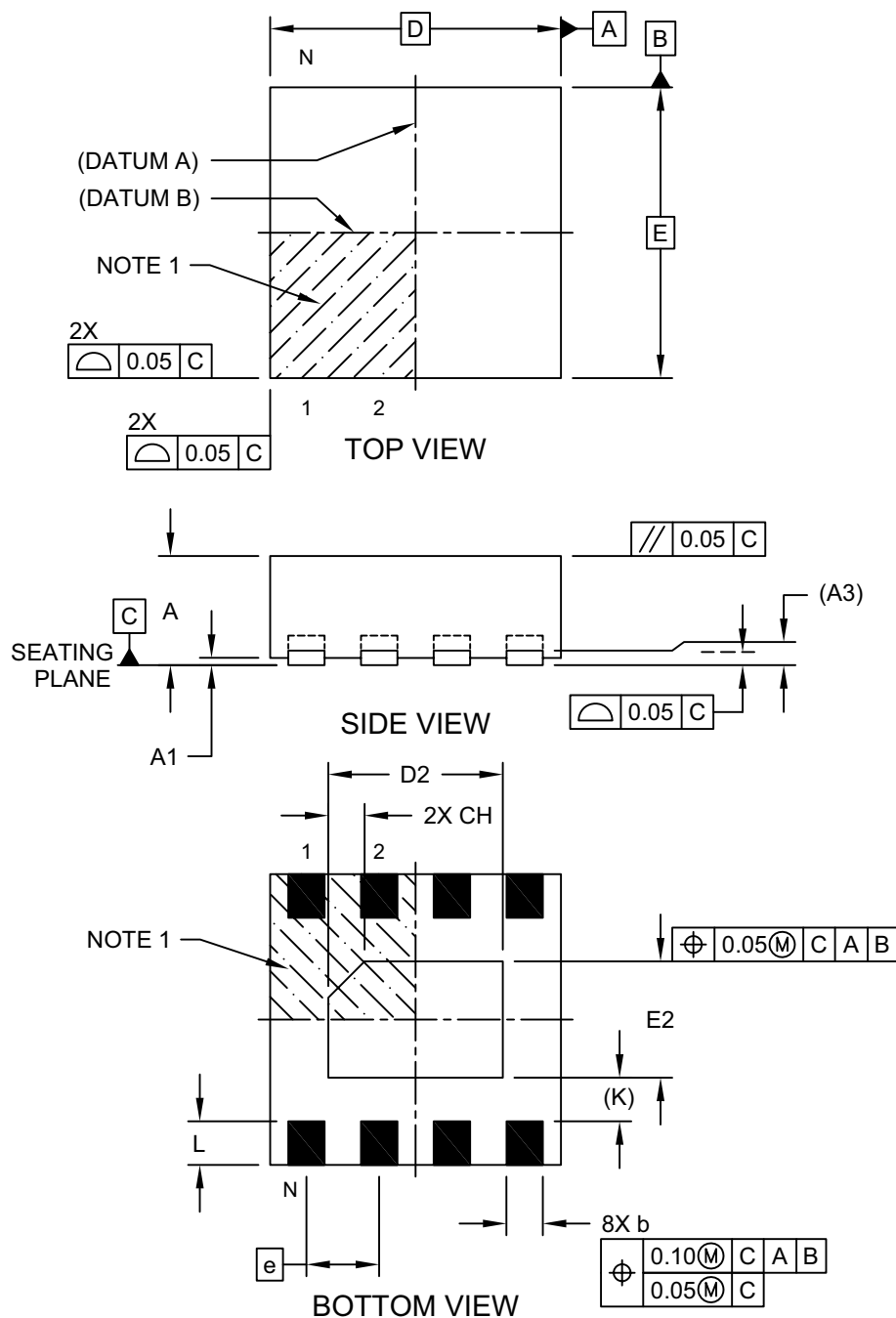
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2057A

MCP14A0451/2

8-Lead Very, Very Thin Plastic Dual Flat, No Lead Package (RW) - 2x2 mm Body [WDFN]

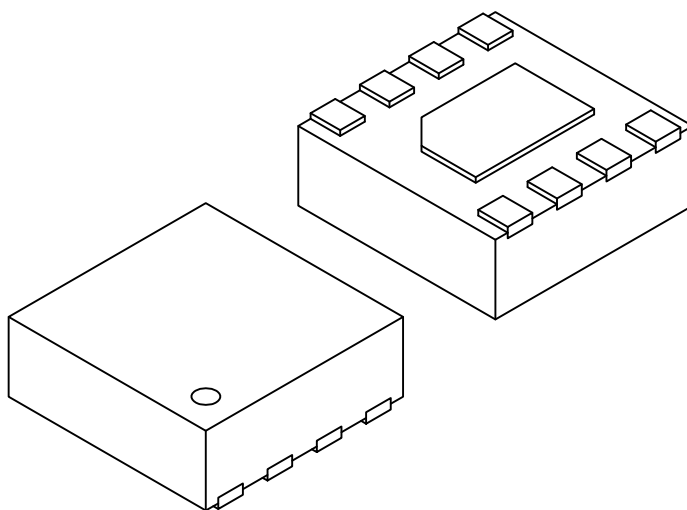
Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing C04-261A Sheet 1 of 2

8-Lead Very, Very Thin Plastic Dual Flat, No Lead Package (RW) - 2x2 mm Body [WDFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Number of Terminals	N	8		
Pitch	e	0.50 BSC		
Overall Height	A	0.70	0.75	0.80
Standoff	A1	0.00	0.02	0.05
Terminal Thickness	(A3)	0.10 REF		
Overall Width	E	2.00 BSC		
Exposed Pad Width	E2	0.70	0.80	0.90
Overall Length	D	2.00 BSC		
Exposed Pad Length	D2	1.10	1.20	1.30
Exposed Pad Chamfer	CH	-	0.25	-
Terminal Width	b	0.20	0.25	0.30
Terminal Length	L	0.25	0.30	0.35
Terminal-to-Exposed-Pad	(K)	0.30	-	-

Notes:

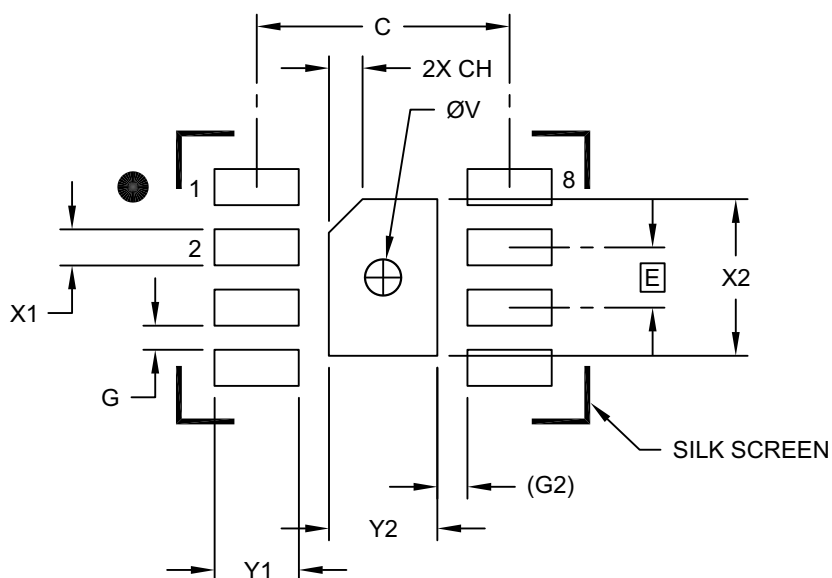
- Pin 1 visual index feature may vary, but must be located within the hatched area.
- Package is saw singulated
- Dimensioning and tolerancing per ASME Y14.5M
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.
 - REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-261A Sheet 2 of 2

MCP14A0451/2

8-Lead Very, Very Thin Plastic Dual Flat, No Lead Package (RW) - 2x2 mm Body [WDFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	0.50 BSC		
Optional Center Pad Width	Y2			0.90
Optional Center Pad Length	X2			1.30
Contact Pad Spacing	C		2.10	
Center Pad Chamfer	CH		0.28	
Contact Pad Width (X8)	X1			0.30
Contact Pad Length (X8)	Y1			0.70
Contact Pad to Contact Pad (X6)	G1	0.20		
Contact Pad to Center Pad (X8)	G1		0.25 REF	
Thermal Via Diameter	V		0.30	

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerances, for reference only.

Microchip Technology Drawing C04-2261A

APPENDIX A: REVISION HISTORY

Revision A (November 2016)

- Original release of this document.

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

<u>PART NO.</u>	<u>[X]⁽¹⁾</u>	<u>-X</u>	<u>/XX</u>
Device	Tape and Reel	Temperature Range	Package
Device: MCP14A0451T: High-Speed MOSFET Driver (Tape and Reel) MCP14A0452T: High-Speed MOSFET Driver (Tape and Reel)			
Temperature Range: E = -40°C to +125°C (Extended)			
Package: MS = Plastic Micro Small Outline Package (MSOP), 8-lead SN = Plastic Small Outline Package (SOIC), 8-lead RW = Plastic Dual Flat, No Lead Package - 2 x 2 mm Body (WDFN) 8-lead			

Examples:
a) MCP14A0451T-E/MS: Tape and Reel, Extended temperature, 8LD MSOP package
b) MCP14A0452T-E/SN: Tape and Reel, Extended temperature, 8LD SOIC package
c) MCP14A0452T-E/RW: Tape and Reel, Extended temperature, 8LD WDFN package

Note 1: Tape and Reel identifier only appears in the catalog part number description. This identifier is used for ordering purposes and is not printed on the device package. Check with your Microchip Sales Office for package availability with the Tape and Reel option.

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